



0.4Ω, 3.3V, Quad SPDT Analog Switch

## Features

- → CMOS Technology for Bus and Analog Applications
- Low On-Resistance:  $0.4\Omega$  (+2.7V Supply) →
- → Wide VCC Range: +1.6V to +4.2V
- 1.8V Logic Control Tolerable →
- Rail-to-Rail switching throughout Signal Range →
- Fast Switching Speed: 20ns TYP. at 3.3V →
- High Off Isolation: -65dB →
- Crosstalk Rejection: -65dB →
- Extended Industrial Temperature Range: -40°C to 85°C →
- → 3kV HBM ESD protection
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2) →
- Halogen and Antimony Free. "Green" Device (Note 3) →
- For automotive applications requiring specific change control → (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/guality/product-definitions/

- Packaging: (Pb-free & Green) →
  - I6-contact TQFN (ZH), 3.0mm x 3.0mm

# **Applications**

- Cell Phones →
- **PDAs** →
- Portable Instrumentation →
- **Battery Powered Communications** →
- → **Computer Peripherals**
- Audio & Video Signal Routing →
- PCMCIA Cards →
- Modems →
- → Hard Drives
- JTAG Testing →

# Description

The PI3A412 is a quad single-pole double-throw (SPDT) CMOS switch. It can be used as an analog switch or as a low-delay bus switch. Specified over a wide operating power supply voltage range, +1.6V to +4.2V, the switch has an On-Resistance of  $0.4\Omega$  at 2.7V.

Control inputs, Ax, tolerates input drive signals up to 5V, independent of supply voltage.



Notes:

2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

<sup>1.</sup> No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.





# **Pin Configuration**



# **Pin Description**

Pin #	Pin Name	Description	
4, 8, 12, 16	COMX	Common Output / Data Port	
1, 5, 9, 13	NCX	Data Port (normally connect)	
3, 7, 11, 15	NOX	Data Port (normally open)	
2, 10	A <sub>0</sub> , A <sub>1</sub>	Logic Input Control	
6	GND	Ground	
14	V <sub>CC</sub>	Positive Power Supply	

Notes :

1. X = 1, 2, 3, or 4

## **Function Tables**

A <sub>0</sub>	Function	A <sub>1</sub>	Function
0	$NC_X$ Connected to $COM_X$	0	NC <sub>Y</sub> Connected to COM <sub>Y</sub>
1	NO <sub>X</sub> Connected to COM <sub>X</sub>	1	NO <sub>Y</sub> Connected to COM <sub>Y</sub>

#### Notes :

1. X = 1 or 2

2. Y = 3 or 4





#### **Absolute Maximum Ratings Thermal Information** Voltages Referenced to GND Continuous Power Dissipation 16-pin Thin QFN (derate 7.1mW/°C above +70°C)...... 0.5W $V_{NOx}, V_{NCx}, V_{COMx}, V_{Ax} \,^{(1)}$ .....-0.5V to $V_{+}$ +0.3V or 30mA, whichever occurs first Storage Temperature .....-65°C to +150°C Lead Temperature (soldering, 10s) ..... +300°C Current (any terminal).....±400mA Peak Current, $V_{NC}$ + $V_{NO}$ (Pulsed at 1ms, 10% duty cycle)...... $\pm 500 mA$

Note 1: Signals on NC, NO, COM, or A exceeding V<sub>CC</sub> or GND are clamped by internal diodes. Limit forward diode current to 30mA.

Caution: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied.

## **Electrical Specifications - Single +3.3V Supply**

 $(V_{CC} = +3.3V \pm 10\%, GND = 0V, V_{IH} = 1.3V, V_{IL} = 0.5V)$   $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C)$ 

Symbol	Parameter	Conditions	Min. <sup>(1)</sup>	Typ. <sup>(2)</sup>	Max. <sup>(1)</sup>	Units
VANALOG	Analog Signal Range <sup>(3)</sup>		0		V <sub>CC</sub>	V
R <sub>ON</sub>	On Resistance			0.4	0.6	
ΔR <sub>ON</sub>	On-Resistance Match Between Channels <sup>(4)</sup>	$v_{\rm CC} = 2.7 v, r_{\rm COM} = 100 \text{mA}, v_{\rm IN} = +1.5 \text{V}$		0.08	0.09	Ω
R <sub>FLAT(ON)</sub>	On-Resistance Flatness <sup>(5)</sup>	V <sub>CC</sub> = 2.7V, I <sub>COMx</sub> = 100mA, V <sub>IN</sub> = 0.8V, 2.0V		0.1	0.15	
$I_{NC} (off)$ or $I_{NO} (off)$	Off Leakage Current <sup>(6)</sup>	$V_{CC} = 3.6V, V_{NO} \text{ or } V_{NC} = 0.3V,$ 3.3V	-400		400	nA
I <sub>COMx (on)</sub>	On Leakage Current <sup>(6)</sup>	$V_{CC} = 3.6V, V_{COMx} = 0.3V, 3.3V$	-400		400	

Notes:

The algebraic convention, where most negative value is a minimum and most positive is a maximum, is used in this data sheet. 1.

Typical values are  $T_A = 25^{\circ}C$ ,  $V_{CC} = 3.3V$  unless otherwise specified. 2.

3. Guaranteed by design.

 $\Delta R_{ON} = R_{ON}$  match between channels 4.

Flatness is defined as the difference between the maximum and minimum value of On-Resistance measured. 5.

Leakage parameters are 100% tested at maximum rated hot temperature and guaranteed by correlation at +25°C. 6.





## **Electrical Specifications - Single +4.2V Supply**

 $(V_{CC} = +4.2V, GND = 0V, V_{IH} = 1.6V, V_{IL} = 0.7V) (T_A = -40^{\circ}C \text{ to } +85^{\circ}C)$ 

Symbol	Parameter	Conditions	Min. <sup>(1)</sup>	Typ. <sup>(2)</sup>	Max. <sup>(1)</sup>	Units
VANALOG	Analog Signal Range <sup>(3)</sup>		0		V <sub>CC</sub>	V
R <sub>ON</sub>	On Resistance			0.4	0.6	
ΔR <sub>ON</sub>	On-Resistance Match Between Channels <sup>(4)</sup>	$v_{\rm CC} = 4.0$ v, $r_{\rm COMx} = 100$ mA, $v_{\rm IN} = +1.5$ V		0.08	0.09	Ω
R <sub>FLAT(ON)</sub>	On-Resistance Flatness <sup>(5)</sup>	V <sub>CC</sub> = 4.0V, I <sub>COMx</sub> = 100mA, V <sub>IN</sub> = 0.8V, 2.0V		0.1	0.15	
I <sub>NC</sub> (off) or I <sub>NO</sub> (off)	Off Leakage Current <sup>(6)</sup>	$V_{CC} = 4.2V$ , $V_{NO}$ or $V_{NC} = 0.3V$ , 3.3V	-500		500	nA
I <sub>COMx</sub> (on)	On Leakage Current <sup>(6)</sup>	$V_{CC} = 4.2V, V_{COMx} = 0.3V, 3.3V$	-500		500	

Notes:

1. The algebraic convention, where most negative value is a minimum and most positive is a maximum, is used in this data sheet.

2. Typical values are  $T_A = 25^{\circ}C$ ,  $V_{CC} = 4.2V$  unless otherwise specified.

Guaranteed by design. 3.

4.  $\Delta R_{ON} = R_{ON}$  match between channels

5. Flatness is defined as the difference between the maximum and minimum value of On-Resistance measured.

6. Leakage parameters are 100% tested at maximum rated hot temperature and guaranteed by correlation at +25°C.





## **Electrical Specifications - Single +4.2V Supply**

 $(V_{CC} = +4.2V, GND = 0V, V_{IH} = 1.6V, V_{IL} = 0.7V) (T_A = -40^{\circ}C \text{ to } +85^{\circ}C)$ 

Parameter	Description	Test Conditions	Min. <sup>(1)</sup>	Typ. <sup>(2)</sup>	Max. <sup>(1)</sup>	Unit		
Logic Input								
V <sub>IH</sub>	Input High Voltage	Guaranteed logic High Level	1.6			N7		
V <sub>IL</sub>	Input Low Voltage	Guaranteed logic Low Level			0.7	v		
I <sub>AH</sub>	Input Current with Voltage High	$V_A = 1.4V$ , all others = $0.5V$	-1		1	A		
I <sub>AL</sub>	Input Current with Voltage Low	$V_A = 0.5V$ , all other = $1.4V$	-1		1	μΑ		
Dynamic								
t <sub>ON</sub>	Turn-On Time	$V_{CC} = 4.2V, V_{COM} = 2.0V,$ Figure 1		20	25			
t <sub>OFF</sub>	Turn-Off Time	& 2		12	15	ns		
t <sub>BBM</sub>	Break-Before-Make	$V_{IN} = 1.5V$ , $R_L = 50\Omega$ , $C_L = 35pF$ , See Figure 3	1	12	15	115		
Q	Charge Injection <sup>(3)</sup>	$C_L = 1nF$ , $V_{GEN} = 0V$ , $R_{GEN} = 0\Omega$ , Figure 4		100		pC		
O <sub>IRR</sub>	Off Isolation <sup>(4)</sup>	$R_L = 50\Omega$ , f = 100kHz, Figure 5		-65		10		
X <sub>TALK</sub>	Cross Talk <sup>(5)</sup>	$R_L = 50\Omega$ , f = 100kHz, Figure 6		-65		đВ		
f <sub>3db</sub>	3dB Bandwidth	See Test Circuit Figure 9		40		MHz		
C <sub>NC(OFF)</sub>	Off Capacitance			50				
C <sub>NO(OFF)</sub>	Off Capacitance	f = 1 MHz, Figure 7 f = 1 MHz, Figure 8		50		pF		
C <sub>ON</sub>	On Capacitance			135				
Supply								
V <sub>CC</sub>	Power-Supply Range		1.5		4.4	V		
I <sub>CC</sub>	Positve Supply Current	$V_{CC} = 4.2V$ , $V_A = 0V$ or $V_{CC}$			40	μΑ		

Notes:

The algebraic convention, where most negative value is a minimum and most positive is a maximum, is used in this data sheet. 1.

Typical values are  $T_A = 25^{\circ}C$ ,  $V_{CC} = 4.2V$  unless otherwise specified. 2.

Guaranteed by design. 3.

4. Off Isolation =  $20\log_{10} [(V_{NO} \text{ or } V_{NC}) / V_{COM}]$ . See Figure 5.

5. Between any two switches. See Figure 6.





## **Electrical Specifications - Single +3.3V Supply**

 $(V_{CC} = +3.3V \pm 10\%, \text{GND} = 0V, V_{IH} = 1.3V, V_{IL} = 0.5V) (T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C})$ 

Parameters	Description	Test Conditions	Min. <sup>(1)</sup>	Typ. <sup>(2)</sup>	Max. <sup>(1)</sup>	Units		
Logic Input								
V <sub>IH</sub>	Input High Voltage	Guaranteed logic High Level	1.3			V		
V <sub>IL</sub>	Input Low Voltage	Guaranteed logic Low Level	eed logic Low Level 0.5		0.5	v		
I <sub>AH</sub>	Input Current with Voltage High	$V_A = 1.4V$ , all others = $0.5V$	-1		1			
I <sub>AL</sub>	Input Current with Voltage Low	$V_A = 0.5V$ , all other = $1.4V$	-1		1	μΑ		
Dynamic	<b>`</b>		·					
t <sub>ON</sub>	Turn-On Time	$V_{CC} = 3.3V, V_{COM} = 2.0V,$ Figure 1		20	25			
t <sub>OFF</sub>	Turn-Off Time	& 2		12	15			
t <sub>BBM</sub>	Break-Before-Make	$V_{IN} = 1.5V,$ $R_L = 50\Omega,$ $C_L = 35pF,$ See Figure 3	1	12	15	ns		
Q	Charge Injection <sup>(3)</sup>	$C_{L} = 1nF, V_{GEN} = 0V,$ $R_{GEN} = 0\Omega, Figure 4$		100		pC		
O <sub>IRR</sub>	Off Isolation <sup>(4)</sup>	$R_L = 50\Omega$ , $f = 100$ kHz, Figure 5		-65		Π		
X <sub>TALK</sub>	Cross Talk <sup>(5)</sup>	$R_L = 50\Omega$ , f = 100kHz, Figure 6		-65		aв		
f <sub>3db</sub>	3dB Bandwidth	See Test Circiut Figure 9		40		MHz		
C <sub>NC(OFF)</sub>	Off Capacitance			50				
C <sub>NO(OFF)</sub>	Off Capacitance	1 = 1 MITIZ, Figure /		50		pF		
C <sub>ON</sub>	On Capacitance	f = 1 MHz, Figure 8		135				

#### Notes:

The algebraic convention, where most negative value is a minimum and most positive is a maximum, is used in this data sheet. 1.

2. Typical values are  $V_{CC} = 3.3V$  unless otherwise specified.

3. Guaranteed by design.

Off Isolation =  $20\log_{10} [(V_{NO} \text{ or } V_{NC}) / V_{COM}]$ . See Figure 5. 4.

5. Between any two switches. See Figure 6.





# **Test Circuits and Timing Diagrams**



### Notes:

Unused N<sub>X</sub> inputs must be grounded.



## Figure 2. AC Waveforms



### Figure 3. Break Before Make Interval Timing







## **Figure 4. Charge Injection Test**



**Figure 5. Off Isolation** 



Figure 7. Channel Off Capacitance





Figure 8. Channel On Capacitance







Figure 9. Bandwidth

# **Part Marking**



PI3A412ZHE = A4ZHEZ: Die Rev Y: Date Code (Year) W: Date Code (Workweek) 1st X: Assembly Site Code 2nd X: Fab Site Code Bar above Fab Code means Cu wire





# Packaging Mechanical: 16-TQFN (ZH)



#### For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

## **Ordering Information**

Ordering Code	Package Code	Package Description
PI3A412ZHEX	ZH	16-contact, W-QFN3030-16 (TQFN)

#### Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. E = Pb-free and Green

5. X suffix = Tape/Reel





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